Sea	rch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/715,045	SENDYK ET AL.
Examiner	Art Unit
Yuwen Pan	2618

SEARCHED			
Class	Subclass	Date	Examiner
455	101,105,1 03,114.2	12/6/2006	YP
	126		
375	141		
	146-148		
370	334,339		
	209,441		,
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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(INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	12/6/2006	YP		
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